

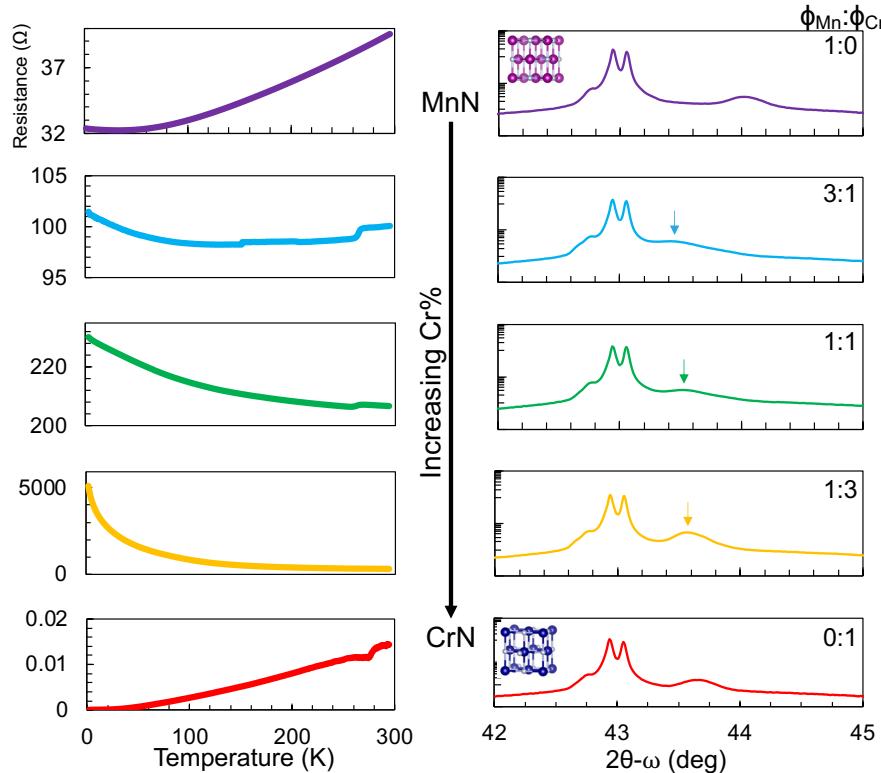
Molecular Beam Epitaxy of Binary and Ternary Manganese and Chromium Nitrides.

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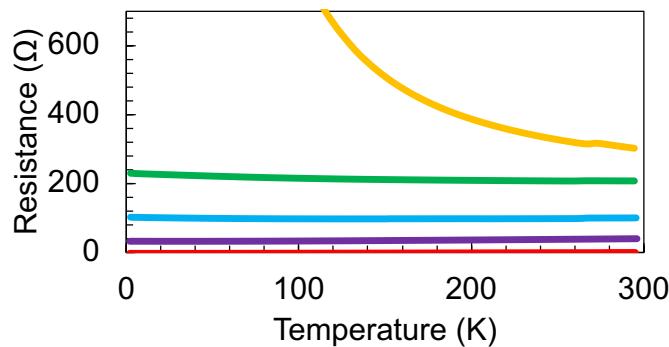
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Left column: Resistance vs temperature for $\text{Mn}_x\text{Cr}_y\text{N}$ with increasing amounts of Cr (purple to red). The binary compounds are metallic, while the ternaries are semiconducting.

Right column: X-ray diffraction for the same $\text{Mn}_x\text{Cr}_y\text{N}$ samples deposited on MgO (001) substrates, the corresponding beam equivalent pressure ratio ($\Phi_{\text{Mn}}:\Phi_{\text{Cr}}$) are shown in the top right of each panel. The ternary compounds fall outside of the two binaries, suggesting a non-rocksalt phase.



The same resistance vs temperature data as shown above, but on the same y-axis. The $\text{Mn}_x\text{Cr}_y\text{N}$ sample with $\Phi_{\text{Mn}}:\Phi_{\text{Cr}}$ of 1:3 shows the largest drop in resistance